- Functionally Equivalent to AMD's AM29825
- Improved ІОн Specifications
- Multiple Output Enables Allow Multiuser Control of the Interface
- Outputs Have Undershoot-Protection Circuitry
- Power-Up High-Impedance State
- Buffered Control Inputs Reduce dc Loading Effects
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (NT) and Ceramic (JT) 300-mil DIPs


## description

These 8 -bit flip-flops feature 3 -state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. These devices are particularly suitable for implementing multiuser registers, I/O ports, bidirectional bus drivers, and working registers.
With the clock-enable ( $\overline{\text { CLKEN }}$ ) input low, the eight D-type edge-triggered flip-flops enter data on the low-to-high transitions of the clock (CLK) input. Taking CLKEN high disables the clock buffer, latching the outputs. These devices have noninverting data (D) inputs. Taking the clear (CLR) input low causes the eight Q outputs to go low independently of the clock.

Multiuser buffered output-enable ( $\overline{\mathrm{OE}}, \overline{\mathrm{OE} 2}$, and OE3) inputs can be used to place the eight outputs in either a normal logic state (high or low logic level) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The highimpedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

The output enables do not affect the internal operation of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The SN54AS825A is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The SN74AS825A is characterized for operation from $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$.

FUNCTION TABLE
(each flip-flop)

| INPUTS |  |  |  |  | OUTPUT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| y $\overline{\text { OE } \dagger}$ | $\overline{\text { CLR }}$ | $\overline{\text { CLKEN }}$ | CLK | D | Q |
| L | L | X | X | X | L |
| L | H | L | $\uparrow$ | H | H |
| L | H | L | $\uparrow$ | L | L |
| L | H | H | X | X | $\mathrm{Q}_{0}$ |
| H | X | X | X | X | Z |

$\dagger \overline{\mathrm{OE}}=\mathrm{H}$ if any of $\overline{\mathrm{OE}}, \overline{\mathrm{OE}} 2$, or $\overline{\mathrm{OE}} 3$ are high.
$\overline{\mathrm{OE}}=\mathrm{L}$ if all of $\overline{\mathrm{OE} 1}, \overline{\mathrm{OE} 2}$, or $\overline{\mathrm{OE} 3}$ are low.

## logic symbol $\ddagger$


$\ddagger$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the DW, JT, and NT packages.

## logic diagram (positive logic)



Pin numbers shown are for the DW, JT, and NT packages.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

Supply voltage, $\mathrm{V}_{\mathrm{CC}}$

$\dagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
recommended operating conditions

|  |  |  |  | 4AS82 |  |  | 4AS82 |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage |  | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage |  | 2 |  |  | 2 |  |  | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-level input voltage |  |  |  | 0.7 |  |  | 0.8 | V |
| $\mathrm{IOH}^{\text {I }}$ | High-level output current |  |  |  | -24 |  |  | -24 | mA |
| IOL | Low-level output current |  |  |  | 32 |  |  | 48 | mA |
|  |  | $\overline{\mathrm{CLR}}$ low | 7 |  |  | 4 |  |  |  |
| ${ }^{\text {w }}$ | Pulse duration | CLK high or low | 9.5 |  |  | 8 |  |  | ns |
|  |  | $\overline{\text { CLR }}$ inactive | 8 |  |  | 8 |  |  |  |
| $\mathrm{t}_{\text {su }}{ }^{*}$ | Setup time before CLK $\uparrow$ | Data | 7 |  |  | 6 |  |  | ns |
|  |  | $\overline{\text { CLKEN }}$ high or low | 10 |  |  | 6 |  |  |  |
| $t^{*}{ }^{*}$ | Hold time after CLK $\uparrow$ | $\overline{\text { CLKEN }}$ low or data | 0 |  |  | 0 |  |  | ns |
| $\mathrm{T}_{\text {A }}$ | Operating free-air temperature |  | -55 |  | 125 | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

* On products compliant to MIL-STD-883, Class B, this parameter is based on characterization data but is not production tested.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.
switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R} 1=500 \Omega, \\ & \mathrm{R} 2=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAX } \dagger \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54A | 825A | SN74A | 825A |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| tPLH | CLK | Any Q | 3.5 | 9 | 3.5 | 7.5 | ns |
| tPHL |  |  | 3.5 | 13.5 | 3.5 | 13 |  |
| tPHL | $\overline{\mathrm{CLR}}$ | Any Q | 3.5 | 16.5 | 3.5 | 15.5 | ns |
| tPZH | $\overline{\mathrm{OE}}$ | Any Q | 4 | 12 | 4 | 11 | ns |
| tPZL |  |  | 4 | 13 | 4 | 12 |  |
| tPHZ | $\overline{O E}$ | Any Q | 1 | 10 | 1.5 | 8 | ns |
| tPLZ |  |  | 1 | 10 | 1.5 | 8 |  |

[^0]
## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES:
A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
D. All input pulses have the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, \mathrm{t}_{\mathrm{f}}=\mathrm{t}_{\mathrm{f}}=2 \mathrm{~ns}$, duty cycle $=50 \%$.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

INSTRUMENTS

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5962-9078003M3A | ACTIVE | LCCC | FK | 28 | 42 | Non-RoHS \& Green | SNPB | N/ A for Pkg Type | -55 to 125 | 5962- <br> 9078003M3A <br> SNJ54AS <br> 825AFK | Samples |
| SNJ54AS825AFK | ACtive | LCCC | FK | 28 | 42 | Non-RoHS \& Green | SNPB | N/ A for Pkg Type | -55 to 125 | 5962- <br> 9078003M3A <br> SNJ54AS <br> 825AFK | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free"
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the $<=1000$ ppm threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a " $\sim$ " will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width

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FK (S-CQCC-N**)
LEADLESS CERAMIC CHIP CARRIER 28 TERMINAL SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. Falls within JEDEC MS-004

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[^0]:    $\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

